# Board level design and verification with Genesys

Tips and tricks

Lance Lascari RFdude.com LLC <u>consulting@RFdude.com</u>

June 10<sup>th</sup>, 2009





# **Board level design and verification with Genesys** Introduction

This is meant to be an informal, interactive session for Genesys users; please feel free to ask questions and contribute your perspective, war stories, tips!

The workspaces and circuits presented here will not be available for download, however I am happy to open them up live if you have questions. This is a very small sampling of the work I do with Genesys and simply represents some of the circuits I can show to demonstrate key design points.

If there are questions about other types of circuits I'm happy to discuss them as well (FET mixers, frequency multipliers, detectors, switches, oscillators).



# **Board level design and verification with Genesys** Agenda

To highlight some of our usage patterns with Genesys and share our techniques, the examples we've prepared are in the following areas:

- •Momentum (or EMPOWER) and linear or HB Cosimulation
- •Amplifier stability analysis and verification
- •Reference planes in EM simulation of active circuits
- •Tolerance analysis in printed filters
- Patch antenna radiation patterns
- •Unintentional radiation from microstrip structures



- Why do I use cosimulation or "EM simulation with active and lumped components" constantly?
  - Allows for more compact circuits straight EM analysis of copper that does not conform to disco models available
  - "2<sup>nd</sup> opinion" on model based analysis
  - Speed has increased to the point that it is practical early in the design cycle
- Quick switching between transistor models with sub circuits and variables
- handling dual grounds with two port data and properly handling in EM simulation
- Fast tuning with lumped elements

Now an involved example to demonstrate these points











Presentation © 2009 RFdude.com LLC June 1, 2009



Agreement fairly decent for this example

"ripple" in Momentum results perhaps due to interpolation ?

Note: I used Modelithics models for the R's and C's here.





Stability factors for various analyses

More discussion on this later



Momentum is fast, but minimizing runs is key to speeding your design cycle.

- Once the copper is settled (no touching the layout), the momentum dataset will remain valid without a new simulation run
  - Use **variables** to tune lumped elements (R's, C's, L's) : this is the one point of reference for the values
    - Do not use the "tuned" option on the schematic elements (for R, L, C, or sources) as they will proliferate and become out of sync with a harbec cosimulation. Tying these to variables in an equation window removes the problem.
      - <u>Reason this is a problem</u>: creating a cosimulation design makes a copy of all non-copper elements on the schematic
  - Tuning a value will leave the component type and footprint the same
  - Another benefit to putting some of this information in equation blocks is that common parameters (bypass capacitor values for example) is that you can cut and paste them easily between workspaces for projects in the same technology/frequency range.





Two tone intermodulation test – this is done using a momentum cosimulation (EM analysis is run on the metal and reconnected to the lumped/nonlinear elements for HB simulation)

Cosim nice for nonlinear circuits since harmonic terminations can be accurately represented



For circuits that you may wish to run several types of analyses on (compression, two-tone intermodulation, etc), consider a "test bench" approach.

•Create a schematic that calls your circuit as a subsystem – your circuit can be a schematic or a momentum cosimulation.

•Is it clear to users what a "cosimulation design" is?

•This way you can leave your circuit (and the input port connected to it) alone and setup the drive levels/frequencies in each testbench.





Quick switching between transistor models with sub circuits and variables

This is a great trick for reconfiguring circuits on the fly for different analyses: Basically one tuned variable controls the values of several resistors that are used as open or short circuits. In this case, tuning the "s2p" variable > 1 will connect the S2P model data. When "s2p" is < 1, the nonlinear model is connected.

This also shows how the two emitters are connected.

```
(workspace equation block)
s2p=?0.998
r_s2p=iff(s2p>1,.00001,1e12)
r_nl=iff(s2p>1,1e12,.00001)
```





Schematic symbol and footprint below map the model between the schematic/subcircuit/EM data







Circuit instability; especially for communications circuits such as Low noise amplifiers and power amplifiers which are exposed to antennas (LNA, PA) represent the largest group of *preventable* problems I see.

The "it seems to work" attitude masks so many of these types of problems.

- Testing units exclusively in 50 ohm environment at room temperature.
- You're lucky if you actually see an oscillation occur when looking for it
- Needle in a haystack (temperature, frequency, input/output impedance).
- We need to see roughly \*how\* stable our designs are



- I always use measured data as part of a verification step; mainly to compute the stability factors.
- There are several ways to gather and use measured data, I prefer to create another linear simulation and subcircuit for the two port data for the following reasons:
- 1. One point of reference to the data file; all of your graphs and post-processing can "point" to the linear analysis dataset. I often measure and adjust several times so this saves a great deal of effort
- 2. With the simple schematic such as below you can perform various tests or deembedding. This schematic shows one of our favorite "Litmus" tests for measured data
- 3. My opinion on the matter is that this verification in situ can be done with coaxial pigtails to facilitate the measurement of your final hardware; the key is to make an effort to catch stability problems before you ship! By all means, make the best measurement you can, but make the measurement!







Several years ago after insisting on measuring every amplifier built from DC-daylight I realized that noisy measured data could lead to unnecessary concern. For a wide sweep on a narrowband amplifier it is expected that the input and/or output impedance may appear almost completely reflective and with the inaccuracies and noise in measurements this could "compute" as potentially unstable. I've even measured barrel connectors that were unstable. So I wanted to come up with a way to sort out the "real" problems.

So my approach to "test" the measured data is to add a tiny bit of loss to see if this cleans up the result. My experience is that typically this does when the instability is far out of band and not "real" – but it rarely does much to any real instability present.





Below is an example of the stability factors computed for a model based simulation, momentum cosimulation and a measured dataset. At first glance there seems to be a serious potential instability based on the measured data near 15 GHz and below 1 GHz. It doesn't take much shunt conductance to completely "stabilize".





 $\mu$  (mu) is a handy stability factor that is not built into Genesys. It can be added as a equation in a library so it is available at all times. Below is an example implementation.

```
function mu(S)
delt=(S[1,1]*S[2,2])-(S[1,2]*S[2,1])
num=1-abs(S[1,1]*S[1,1])
den=abs(S[2,2]-(conj(S[1,1])*delt)) +abs(S[2,1]*S[1,2])
result=num/den
return result
end
```



As long as the equation library is enabled, you can call the "mu" function as shown in the graph dialog to the right.

Note this is the new 2009.04 graph dialogs and shows some mixed (but compatible) syntax as a carry over from previous versions.

See the "Context" column is now separate from the Variable.

🛃 K Proper	rties								×		
<u>N</u> ame:		к		Graph Iype: 💹 Rectangular Graph				•			
<u>G</u> rap	oh Heading:	к		Show All Columns							
		Context	Variable	Label (Optional)	On Right	Hide?	Color	Туре	Â		
Edit	Remove	Linear1_Data	k	linear k			- 1	General	1		
Edit	Remove	momentum_amp_d	k	momentum			- 1	General			
Edit	Remove	Linear2_Data	k	meas k			<b>-</b>	General			
Edit	Remove	Linear1_Data	mu(S)	linear mu			<b>-</b>	General			
Edit	Remove	momentum_amp_d	mu(momentum_amp_data	momentum				General			
Fdit	Remove	Linear2 Data	mu(S)	meas mu			<b>•</b>	General	<b>T</b>		
X-Axis Y Y-Axis	'-Axis								_		
<u>A</u> u	ito-Scale	Min: 0	Ma <u>x</u> :	<u>x</u> : 5		Units: None 🔻					
Lo	Logarithmic Label: # Divisions: 10										
Advanced     OK     Cancel     Help											



Let us discuss our favorite tricks for stabilizing small signal amplifiers. Here are a few of mine that we can show in the example design:

- "skimping" on the collector/drain bypass capacitor in a LNA
  Splitting resistors in the bias and feedback networks to remove the stub-effects
- •Resistor to copper pad trick.
- •Negative inductance in source/emitter leads -- discuss



## **Board level design and verification with Genesys** Reference planes in EM simulation of active circuits

Reference planes are basically the equivalent physical points on the device (footprint) where the electrical model connects. For many vendors this reference point is at the side of the package, for others it is the end of the leads. Basically we will need to ASK if it is not specified.

Making the wrong assumption here, as I did recently, can be fairly catastrophic.

In the next slide I'll show two footprints for the same device and we can discuss the differences. The default footprints provided with Genesys may not always be the best choices for your design.

- "Understanding Reference Planes for Device Packages" (Eagleware appnote from 2002 that I authored).
- <u>http://cp.literature.agilent.com/litweb/pdf/5989-8905EN.pdf</u>



#### **Board level design and verification with Genesys** Reference planes in EM simulation of active circuits





**Agilent Technologies** 

Presentation © 2009 RFdude.com LLC June 1, 2009

## **Board level design and verification with Genesys** Tolerance analysis in printed filters

Tolerance analysis for circuits is straightforward in Genesys. For circuits that model well with built-in models for coupling and discontinuities; a monte-carlo / yield analysis is probably best.

For "custom" and particularly EMintensive filters, brute force may be the best way using parameter sweeps.

Parameter sweeps are like programming loops – very simple to use.





## **Board level design and verification with Genesys** Tolerance analysis in printed filters





This brute-force technique using nested parameter sweeps is probably the most efficient method for verifying the effect of material properties on the filter response. It could be expanded further to include the copper tolerances as well. This analysis was performed to look specifically at board material tolerance.



# **Board level design and verification with Genesys** Patch antenna radiation patterns

3D antenna patterns available with Momentum GX makes it much simpler to determine antenna performance.

Very nice to be able to view the antenna structure in 3D with the same coordinate axes as the 3D radiation plot. This allows easier diagnosis of anomalies and is inherently more intuitive.

Next we'll discuss a very simple example of how we can identify simple defects in our antennas by viewing the patterns.





#### **Board level design and verification with Genesys** Patch antenna radiation patterns: effect of assymetry in feed of 7.5 GHz two patch array





#### **Board level design and verification with Genesys** Unintentional radiation from microstrip structures

Below is a plot of the response of two notch filters (not very good ones) with 18-19 dB of rejection at 22 GHz.



As far as containing spurious, if the conducted path through the filter is the only outlet for this energy, these two filters should perform quite similarly.

Now we'll look at how these filters interact with their environment.



# **Board level design and verification with Genesys** Unintentional radiation from microstrip structures

Note the differences in radiation pattern (direction) for these filters (@22 GHz)





# **Board level design and verification with Genesys** Join our LinkedIN group!

Linked in Peo	ple∣⊤ Jobs∣⊤ Answers∣⊤ Co	mpanies 🕞	Account & Settings   Help   Sign Out	Canguage
Explore People Search: Enginee	r at IBM - Internet - Senior Consultant	Search People 💌		Search Advanc
Home	Groups		My Groups   Groups Directory	Create a Group   FAQ
Board level RF and Microwave circuit designers	Overview Discussions News	<b>s Users Group</b> Jobs Updates Members Setti	ngs	Group Profile
Agilent Genesys Users Group Defense & Aerospace See all » Profile Edit My Profile View My Profile	Agilent Genesys is t (Electronic Design A RF/MW engineers w and verify a wide ram implemented on printed circuit boards. A simulation technologies ranging from Sy Linear, Transient, and Electromagnetics	he practical, low cost RF EDA utomation) software used by orldwide to synthesize, design, ge of high-frequency circuitry often Agilent Genesys covers all mithesis, System, Linear, Non- ; with links to other EDA tools and	About this Group Created: February 19, 2009 Type: Professional Group Members: 10	
Recommendations Contacts Connections	test & measurement instruments from 1	1 different vendors.	Owner: Mounir Adada Managers: Yap How-Siang	



#### www.linkedin.com

Another group of interest that I started is "Board level RF and Microwave circuit designers"



## **Board level design and verification with Genesys** Summary & Follow-up

We hope that today's discussions have been useful and that MANY ideas have been shared both between Genesys users and with the Agilent team. User input has been a strong force in shaping Genesys over the years that I've used it – so do not hold back on your feedback!

Please do not hesitate to contact me if you have questions about the techniques presented here or about work that we might be able to help your company with in the future.

Thank you for participating!

Lance Lascari RFdude.com LLC

consulting@RFdude.com



